## Refine Search Search Results -**Terms** Documents 10/11/1,198 L3 and current US Pre-Grant Publication Full-Text Database US Patents Full-Text Database US OCR Full-Text Database **EPO Abstracts Database** Database: JPO Abstracts Database **Derwent World Patents Index** IBM Technical Disclosure Bulletins L4 Refine Search Search: Recall Text = Interrupt Clear Search History Printable Copy Create Case DATE: Friday, September 17, 2004 **Set Name Query Hit Count Set Name** side by side result set

7

12

98

194

<u>L4</u>

<u>L3</u>

<u>L2</u>

<u>L1</u>

**END OF SEARCH HISTORY** 

**L4** 

L3

L2

L1

DB=USPT; PLUR=YES; OP=ADJ

L2 and electroplating

L1 and interlayer

wiring adj trench

L3 and current

## **Hit List**

Clear Generate Collection Print Fwd Refs Bkwd Refs
Generate OACS

**Search Results -** Record(s) 1 through 7 of 7 returned.

1. Document ID: US 6790774 B2

L4: Entry 1 of 7

File: USPT

Sep 14, 2004

US-PAT-NO: 6790774

DOCUMENT-IDENTIFIER: US 6790774 B2

TITLE: Method of forming a wiring film by applying high temperature/high pressure

Full Title Chation Front Review Classification Cate Reference Claims Rust Draw Dr

2. Document ID: US 6787293 B2

L4: Entry 2 of 7

File: USPT

Sep 7, 2004

US-PAT-NO: 6787293

DOCUMENT-IDENTIFIER: US 6787293 B2

TITLE: Photoresist residue remover composition

Full Title Citation Front Review Classification Date Reference Section Section Claims FUNC Dravit De

3. Document ID: US 6767826 B2

L4: Entry 3 of 7

File: USPT

Jul 27, 2004

US-PAT-NO: 6767826

DOCUMENT-IDENTIFIER: US 6767826 B2

TITLE: Method of manufacturing semiconductor device

4. Document ID: US 6724653 B1

L4: Entry 4 of 7

File: USPT

Apr 20, 2004

US-PAT-NO: 6724653

DOCUMENT-IDENTIFIER: US 6724653 B1

TITLE: Magnetic random access memory

Full Title Citation Front Review	w: Classification: Date Reference:	Claims KWC Draw:
5. Document ID: US 6	5417575 B2	
L4: Entry 5 of 7	File: USPT	Jul 9, 2002
US-PAT-NO: 6417575 DOCUMENT-IDENTIFIER: US 641	7575 B2	
ITLE: Semiconductor device	and fabrication process therefor	or
Full   Title   Citation   Front   Revie	no Glassification Date References	Claims KWIC Draw
6. Document ID: US	6417094 B1	
L4: Entry 6 of 7	File: USPT	Jul 9, 2002
US-PAT-NO: 6417094 DOCUMENT-IDENTIFIER: US 641 CITLE: Dual-damascene interc	7094 B1 connect structures and methods o	of fabricating same
Full Title Citation Front Revie	will Classification   Date   Reference	Glaims KWC Draw
7. Document ID: US	6245676 B1	
L4: Entry 7 of 7	File: USPT	Jun 12, 2001
US-PAT-NO: 6245676 DOCUMENT-IDENTIFIER: US 624	5676 B1	
CITLE: Method of electropla	ting copper interconnects	
Full Title Chation Front Revie	on Classification Date Reference	Claims   KWIC   Draw
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Clear Generate Collection	n Print Fwd Refs Bkwd	Refs Generate OACS
Clear Generate Collection  Terms  L3 and current	n Print Fwd Refs Bkwd  Documents	Refs Generate OACS

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